Se	arch	Note	S

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/656,333	KITAGAWA ET AL.	
Examiner	Art Unit	
XIAO M. WU	2629	

	SEAR	CHED	
Class	Subclass	Date	Examiner
345	76-79	5/5/2006	X.W.
345	204-206	5/5/2006	X.W.
315	169.3	5/5/2006	X.W.

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH I	NOTES CH STRATEGY	")
	DATE	EXMR
east and inventor search	5/5/2006	x.w.